

Measurement of current pulses due to discharges in a gaseous cavity in solid dielectric

Salvage, B.; Tapupere, Olev Electronics letters : an international publication 1968 / p. 529-530

https://www.ester.ee/record=b2180432*est

Numerical analysis of forward-biased diode structures based on direct-gap semiconductors

Velmre, Enn; Freidin, Boris Electronics letters : an international publication 1979 / p. 383-385

https://www.ester.ee/record=b2180432*est

Numerical simulation of a forward-based p-i-n structure with band-to-band Auger recombination

Freidin, Boris; Velmre, Enn Electronics letters : an international publication 1978 / p. 701-703

https://www.ester.ee/record=b2180432*est

On the sensitivity analysis of linear active networks

Laksberg, Edgar Electronics letters : an international publication 1978 / p.221-223 https://www.ester.ee/record=b2180432*est

State variables and Laguerre series

Kukk, Vello Electronics letters : an international publication 1971 / p. 269-270 https://www.ester.ee/record=b2180432*est

Transient response of sample-and-hold circuits

Gurjanov, Boris Electronics letters : an international publication 1980 / p. 123-124 https://www.ester.ee/record=b2180432*est